

**Notice of References Cited**

Application/Control No.

10/578,102

Applicant(s)/Patent Under

Reexamination

CHOI ET AL.

Examiner

MARCOS BATISTA

Art Unit

4134

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0054807 A1	03-2003	Hsu et al.	455/414
*	B	US-2008/0019322 A1	01-2008	CHANG et al.	370/333
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	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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